

Search Notes**Application/Control No.**

10/619,176

Examiner

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Applicant(s)/Patent under Reexamination

HAMBERG ET AL.

Art Unit

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SEARCHED

Class	Subclass	Date	Examiner
380	255, 259	8/2/2007	MDN
713	176	8/2/2007	MDN
455	410	8/2/2007	MDN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Updated inventor name search on EAST (US-PAT; US-PG-PUB; EPO; JPO; DERWENT; IBM-TDB)	8/2/2007	MDN
Updated text and class search on EAST (US-PAT; US-PG-PUB; EPO; JPO; DERWENT; IBM-TDB)	8/2/2007	MDN